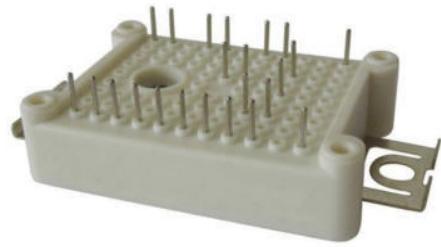




SCOMES

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MRI15.12-PIM IGBT POWER MODULE

Features:

- 10us short circuit capability
- Low switching losses
- VCE(sat) with Positive temperature coefficient
- Fast & soft reverse recovery anti-parallel FWD

Typical Applications:

- Inverter for motor drive(VFD)
- AC and DC servo drive amplifier
- Uninterruptible power supply

IGBT,Inverter

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VALUE			UNIT		
			Min	Type	Max			
V _{CES}	Collector-Emitter voltage	T _j =25°C			1200	V		
V _{GES}	Gate-Emitter voltage	T _j =25°C			±20	V		
I _c	Collector current	Continuous@ T _c =100°C			15	A		
I _{CRM}		t _p =1ms			30	A		
P _{tot}	Total power dissipation	T _c = 25°C, T _{vjmax} =175°C			130	W		
V _{GE(th)}	Gate-Emitter threshold voltage	T _j =25°C ,V _{CE} =20V, I _c =1.20mA	5.2	5.8	6.4	V		
V _{CE(sat)}	Collector-Emitter saturation voltage	T _j =25°C ,V _{GE} =15V, I _c =15A		1.85	2.25	V		
		T _j =25°C ,V _{GE} =15V, I _c =15A		2.15		V		
		T _j =25°C ,V _{GE} =15V, I _c =15A		2.25		V		
Q _g	Gate Charge	V _{GE} =± 15V		0.12		µC		
R _{Gint}	Integrated gate resistor	T _j =25°C		0		Ω		
C _{ies}	Input capacitance	T _j =25°C ,V _{CE} =25V, V _{GE} =0V, f=1MHz		0.89		nF		
C _{res}	Reverse transfer capacitance			0.03		nF		
I _{CES}	Zero gate voltage collector current	T _j =25°C ,V _{CE} =1200V, V _{GE} =0V			1.0	mA		
I _{GES}	Gate-Emitter leakage current	T _j =25°C ,V _{CE} =0V, V _{GE} =±20V	-0.4		0.4	µA		
t _{(d)on}	Turn-on time	V _{CC} =600V, I _c =15A, V _{GE} =±15V, R _{gon} =39Ω, Inductive load	T _j =25°C		55	ns		
			T _j =125°C		55	ns		
			T _j =150°C		55	ns		
t _r			T _j =25°C		59	ns		
			T _j =125°C		65	ns		
			T _j =150°C		65	ns		
t _{(d)off}	Turn-off time	V _{CC} =600V, I _c =15A, V _{GE} =±15V, R _{goff} =39Ω, Inductive load	T _j =25°C		195	ns		
			T _j =125°C		275	ns		
			T _j =150°C		280	ns		
t _r			T _j =25°C		145	ns		
			T _j =125°C		190	ns		
			T _j =150°C		215	ns		
E _{on}	I _c =15 A, V _{CE} =600V, L _s =50nH, V _{GE} =±15 V, di/dt=550A/µs (Tvj = 150°C), R _{Gon} =39 Ω	T _j =25°C		1.30		mJ		
		T _j =125°C		1.75		mJ		
		T _j =150°C		1.95		mJ		
E _{off}	I _c =15 A, V _{CE} =600V, L _s =50nH, V _{GE} =±15 V, di/dt=550A/µs (Tvj = 150°C), R _{Goff} =39 Ω	T _j =25°C		0.83		mJ		
		T _j =125°C		1.20		mJ		
		T _j =150°C		1.35		mJ		

I_{sc}	Short circuit withstand current	$V_{GE}=15V, V_{CC}=800V, V_{CEmax}=V_{CES} - L_{sCE} \cdot di/dt, t_p \leq 10\mu s, T_{vj}=150^\circ C$		55		A
$R_{th(j-c)}$	Thermal resistance, junction to case	per IGBT		1.05	1.15	°C/W
$R_{th(c-h)}$	Thermal resistance, case to heatsink			1.05		°C/W
T_{vjop}	Junction temperature	/	-40		150	°C
T_{stg}	Storage temperature		-40		125	°C
F	mounting force per clamp		20		50	N
W_t	Weight			24		g

Diode, Inverter

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VALUE			UNIT
			Min	Type	Max	
V_{RRM}	Repetitive peak reverse voltage	$T_{vj}=25^\circ C$			1200	V
I_F	Continuous DC forward current				15	A
I_{FRM}	Repetitive peak forward current				30	A
I^2t	I^2t - value	$V_R=0V, t_p=10ms, T_{vj}=150^\circ C$			14	A²s
V_F	Forward on voltage	$I_F=15A$	$T_j=25^\circ C$		2.00	V
			$T_j=125^\circ C$		2.10	V
			$T_j=150^\circ C$		2.10	V
I_{RRM}	Max. reverse recovery current	$I_F=15A, -di_F/dt=550A/\mu s, V_R=600V$	$T_j=25^\circ C$		13	A
			$T_j=125^\circ C$		12	A
			$T_j=150^\circ C$		12	A
Q_r	Recovered charge	$I_F=15A, -di_F/dt=550A/\mu s, V_R=600V$	$T_j=25^\circ C$		1.20	μC
			$T_j=125^\circ C$		2.05	μC
			$T_j=150^\circ C$		2.40	μC
E_{rec}	Reverse recovery energy	$I_F=15A, -di_F/dt=550A/\mu s, V_R=600V$	$T_j=25^\circ C$		0.37	mJ
			$T_j=125^\circ C$		0.68	mJ
			$T_j=150^\circ C$		0.80	mJ
$R_{th(j-c)}$	Thermal resistance, junction to case	per diode			1.75	°C/W
$R_{th(c-h)}$	Thermal resistance, case to heatsink				1.30	°C/W
T_{vjop}	Junction temperature	/	-40		150	°C

Diode, Rectifier

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VALUE			UNIT
			Min	Type	Max	
V_{RRM}	Repetitive peak reverse voltage	$T_{vj}=25^\circ C$			1600	V
I_{FRMSM}	Maximum RMS forward current per chip	$T_c=80^\circ C$			30	A
I_{RMSM}	Maximum RMS current at rectifier output	$T_c=80^\circ C$			30	A
I_{FSM}	Surge forward current	$t_p=10ms, T_{vj}=150^\circ C$			245	A
I^2t	I^2t - value	$V_R=0V, t_p=10ms, T_{vj}=150^\circ C$			300	A²s
V_F	Forward on voltage	$I_F=15A, T_j=150^\circ C$		0.85		V
I_R	reverse current	$V_R=1600V, T_j=150^\circ C$		1.0		mA
$R_{th(j-c)}$	Thermal resistance, junction to case	per diode			1.20	°C/W
					1.15	°C/W
T_{vjop}	Junction temperature	/	-40		150	°C

IGBT, Brake-Chopper

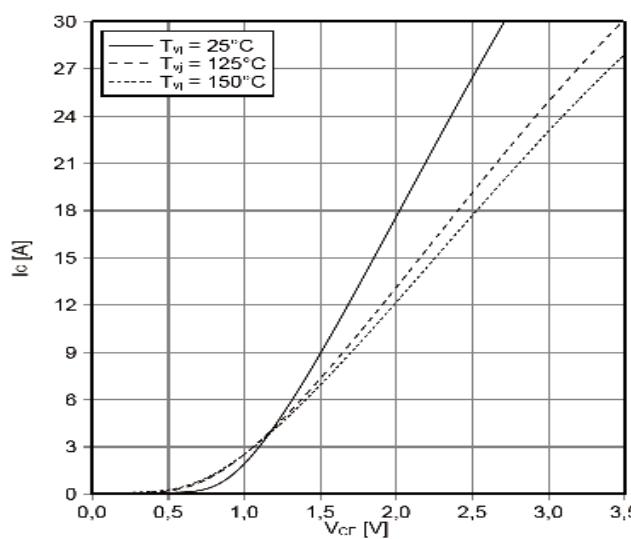
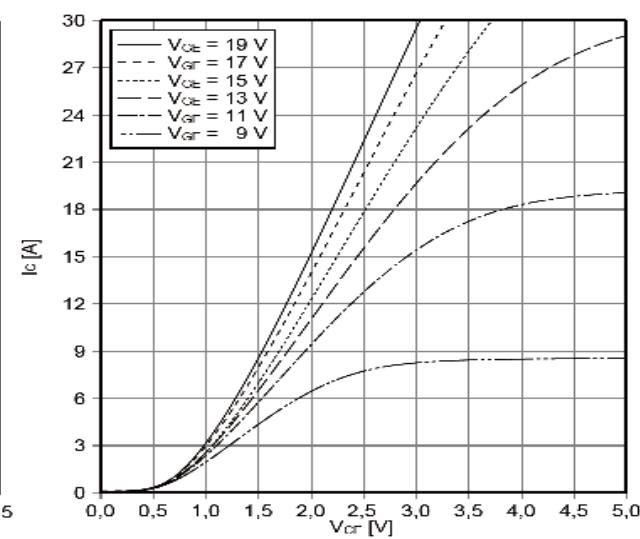
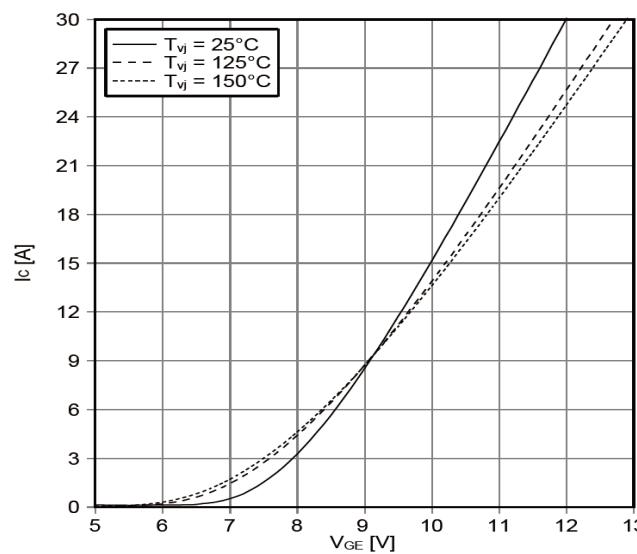
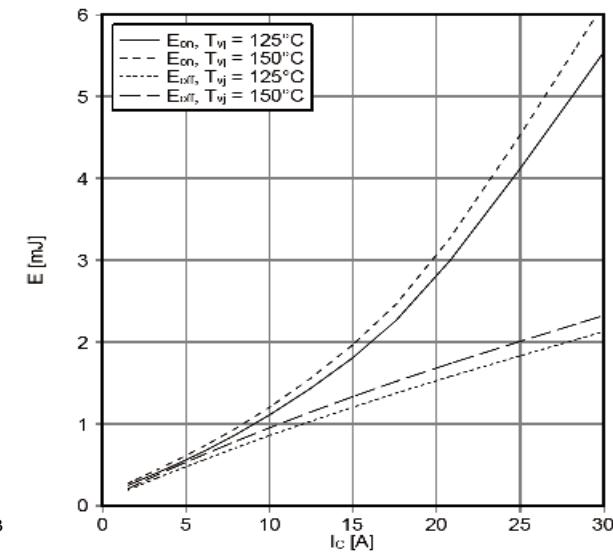
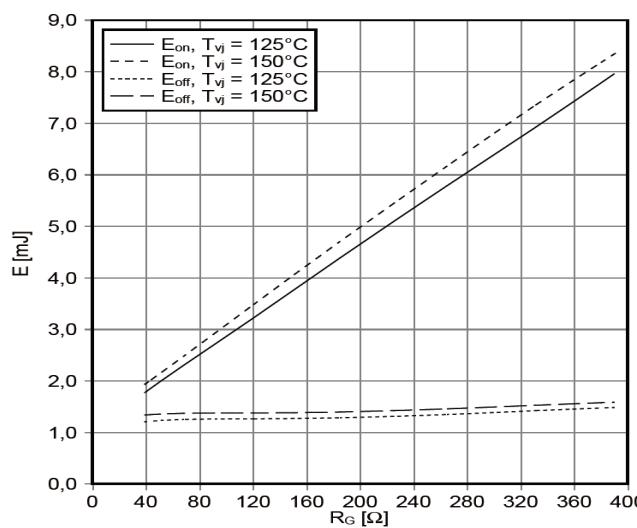
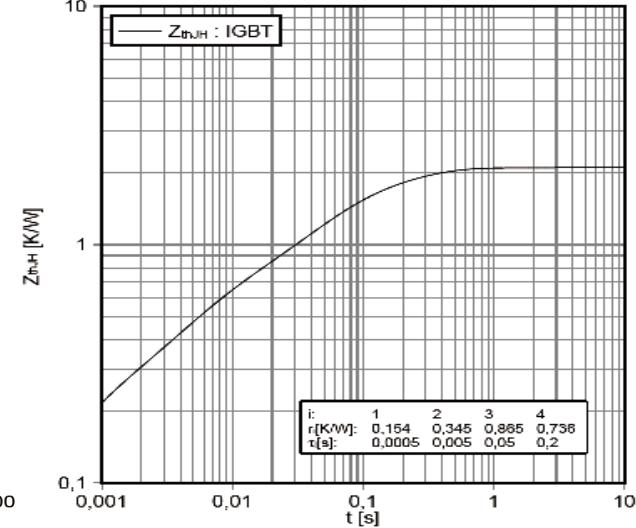
SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VALUE			UNIT		
			Min	Type	Max			
V_{CES}	Collector-Emitter voltage	$T_j=25^\circ C$			1200	V		
V_{GES}	Gate-Emitter voltage	$T_j=25^\circ C$			± 20	V		
I_c	Collector current	Continuous@ $T_c=100^\circ C$			15	A		
		$t_p=1ms$			30	A		
P_{tot}	Total power dissipation	$T_c = 25^\circ C, T_{vjmax}=175^\circ C$			130	W		
$V_{GE(th)}$	Gate-Emitter threshold voltage	$T_j=25^\circ C, V_{CE}=20V, I_c=1.20mA$	5.2	5.8	6.4	V		
$V_{CE(sat)}$	Collector-Emitter saturation voltage	$T_j=25^\circ C, V_{GE}=15V, I_c=35A$		1.85	2.25	V		
		$T_j=25^\circ C, V_{GE}=15V, I_c=35A$		2.15		V		
		$T_j=25^\circ C, V_{GE}=15V, I_c=35A$		2.25		V		
Q_g	Gate Charge	$V_{GE}=\pm 15V$		0.12		μC		
R_{Gint}	Integrated gate resistor	$T_j=25^\circ C$		0		Ω		
C_{ies}	Input capacitance	$T_j=25^\circ C, V_{CE}=25V, V_{GE}=0V, f=1MHz$		0.89		nF		
C_{res}	Reverse transfer capacitance			0.03		nF		
I_{CES}	Zero gate voltage collector current	$T_j=25^\circ C, V_{CE}=1200V, V_{GE}=0V$			1.0	mA		
I_{GES}	Gate-Emitter leakage current	$T_j=25^\circ C, V_{CE}=0V, V_{GE}=\pm 20V$	-0.4		0.4	μA		
$t_{(d)on}$	Turn-on time	$V_{CC}=600V, I_c=15A, V_{GE}=\pm 15V, R_{gon}=43\Omega$, Inductive load	$T_j=25^\circ C$		65	ns		
			$T_j=125^\circ C$		65	ns		
t_r			$T_j=150^\circ C$		65	ns		
			$T_j=25^\circ C$		60	ns		
			$T_j=125^\circ C$		65	ns		
			$T_j=150^\circ C$		65	ns		
$t_{(d)off}$	Turn-off time	$V_{CC}=600V, I_c=15A, V_{GE}=\pm 15V, R_{goff}=43\Omega$, Inductive load	$T_j=25^\circ C$		210	ns		
			$T_j=125^\circ C$		280	ns		
			$T_j=150^\circ C$		285	ns		
			$T_j=25^\circ C$		170	ns		
			$T_j=125^\circ C$		200	ns		
			$T_j=150^\circ C$		225	ns		
E_{on}		$I_c=15 A, V_{CE}=600V, L_s=50nH, V_{GE}=\pm 15 V, R_{Gon}=43 \Omega$	$T_j=25^\circ C$		1.35	mJ		
			$T_j=125^\circ C$		1.80	mJ		
			$T_j=150^\circ C$		2.00	mJ		
E_{off}		$I_c=15 A, V_{CE}=600V, L_s=50nH, V_{GE}=\pm 15 V, R_{Goff}=43 \Omega$	$T_j=25^\circ C$		0.85	mJ		
			$T_j=125^\circ C$		1.20	mJ		
			$T_j=150^\circ C$		1.35	mJ		
I_{sc}	Short circuit withstand current	$V_{GE}=15V, V_{CC}=800V, V_{CEmax}=V_{CES} - L_{sCE} \cdot di/dt, t_p \leq 10\mu s, T_j=150^\circ C$		55		A		
$R_{th(j-c)}$	Thermal resistance, junction to case	per IGBT		1.05	1.15	$^\circ C/W$		
	Thermal resistance, case to heatsink			1.05		$^\circ C/W$		
T_{vjop}	Junction temperature	/	-40		150	$^\circ C$		

Diode, Brake-Chopper

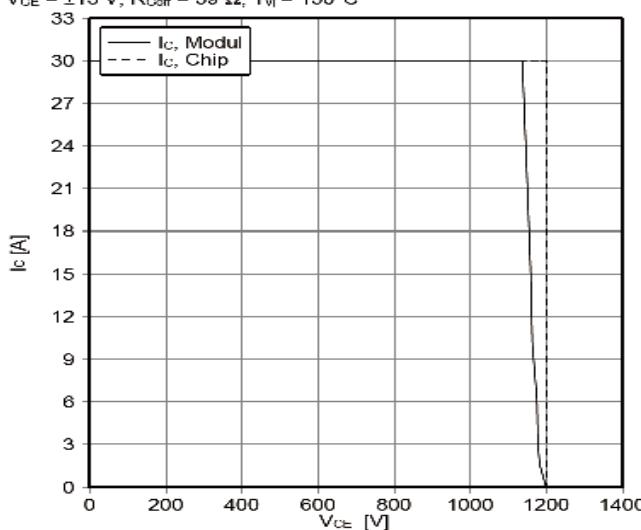
SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VALUE			UNIT
			Min	Type	Max	
V_{RRM}	Repetitive peak reverse voltage	$T_{vj}=25^\circ C$			1200	V
I_F	Continuous DC forward current				10	A
I_{FRM}	Repetitive peak forward current				20	A
I^2t	I^2t - value	$V_R=0V, t_p=10ms, T_{vj}=125^\circ C$			16	A^2s
V_F	Forward on voltage	$I_F=10A, V_{GE}=0V$	$T_j=25^\circ C$	1.75	2.25	V
			$T_j=125^\circ C$	1.75		V
			$T_j=150^\circ C$	1.75		V
I_{RRM}	Max. reverse recovery current	$I_F=10A, -di_F/dt=500A/\mu s, (T_{vj}=150^\circ C), V_R=600 V$	$T_j=25^\circ C$	12		A
			$T_j=125^\circ C$	10		A
			$T_j=150^\circ C$	8		A
Q_r	Recovered charge	$I_F=10A, -di_F/dt=500A/\mu s, V_R=600V$	$T_j=25^\circ C$	0.90		μC
			$T_j=125^\circ C$	1.70		μC
			$T_j=150^\circ C$	1.90		μC
E_{rec}	Reverse recovery energy	$I_F=10A, -di_F/dt=500A/\mu s, V_R=600V$	$T_j=25^\circ C$	0.24		mJ
			$T_j=125^\circ C$	0.52		mJ
			$T_j=150^\circ C$	0.59		mJ
$R_{th(j-c)}$	Thermal resistance, junction to case	per diode		1.75	1.90	$^\circ C/W$
$R_{th(c-h)}$	Thermal resistance, case to heatsink			1.30		$^\circ C/W$
T_{vjop}	Junction temperature	/	-40		150	$^\circ C$

NTC-Thermistor

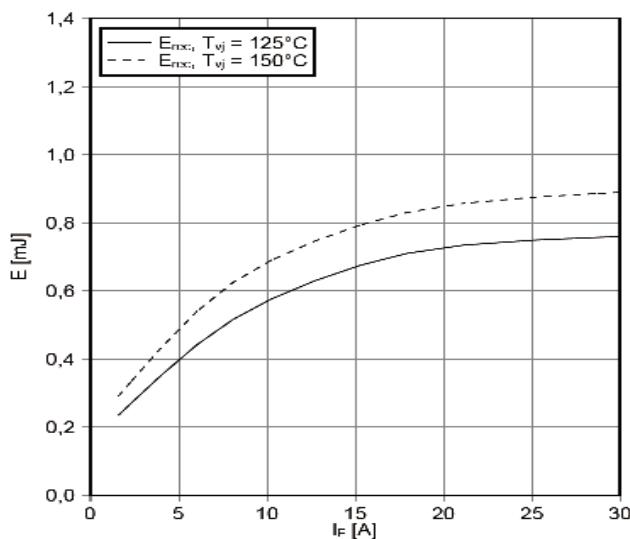
SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VALUE			UNIT
			Min	Type	Max	
R_{25}	Rated resistance	$T_c=25^\circ C$		5.00		$k\Omega$
$\Delta R/R$	Deviation of R100	$T_c=100^\circ C, R_{100}=493W$	-5		5	%
P_{25}	Power dissipation	$T_c=25^\circ C$			20.0	mW
$B_{25/50}$	B-value	$R_2=R_{25} \exp [B_{25/50}(1/T_2-1/(298,15K))]$		3375		K
$B_{25/80}$		$R_2=R_{25} \exp [B_{25/80}(1/T_2-1/(298,15K))]$		3411		K
$B_{25/100}$		$R_2=R_{25} \exp [B_{25/100}(1/T_2-1/(298,15K))]$		3433		K

output characteristic IGBT,Inverter (typical)
 $I_C = f(V_{CE})$
 $V_{GE} = 15 \text{ V}$

output characteristic IGBT,Inverter (typical)
 $I_C = f(V_{CE})$
 $T_{vj} = 150^\circ\text{C}$

transfer characteristic IGBT,Inverter(typical)
 $I_C = f(V_{GE})$
 $V_{CE} = 20 \text{ V}$

switching losses IGBT,Inverter (typical)
 $E_{on} = f(I_C)$, $E_{off} = f(I_C)$
 $V_{CE} = \pm 15 \text{ V}$, $R_{on} = 39 \Omega$, $R_{off} = 39 \Omega$, $V_{GE} = 600 \text{ V}$

switching losses IGBT,Inverter (typical)
 $E_{on} = f(R_G)$, $E_{off} = f(R_G)$
 $V_{GE} = \pm 15 \text{ V}$, $I_C = 15 \text{ A}$, $V_{CE} = 600 \text{ V}$

transient thermal impedance IGBT,Inverter
 $Z_{th,H} = f(t)$


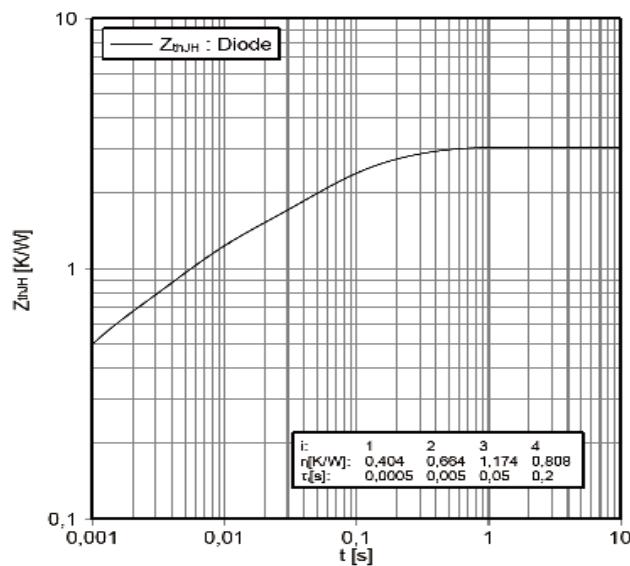
reverse bias safe operating area IGBT,Inverter (RBSOA)
 $I_C = f(V_{CE})$
 $V_{CE} = \pm 15 \text{ V}$, $R_{Gon} = 39 \Omega$, $T_{vj} = 150^\circ\text{C}$



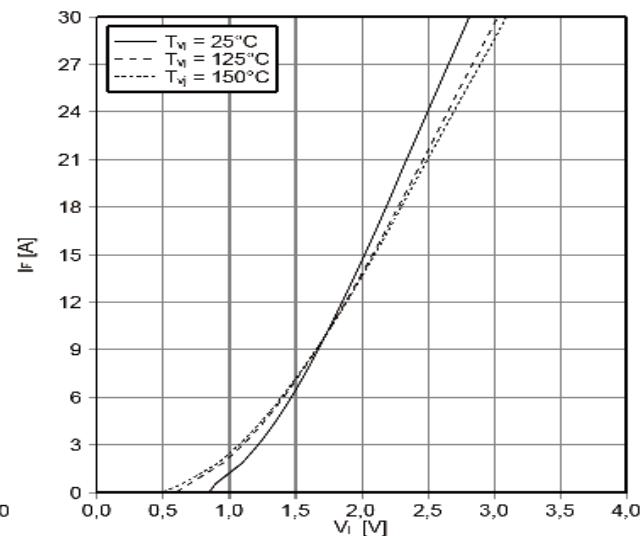
switching losses Diode, Inverter (typical)
 $E_{rec} = f(I_F)$
 $R_{Gon} = 39 \Omega$, $V_{cr} = 600 \text{ V}$



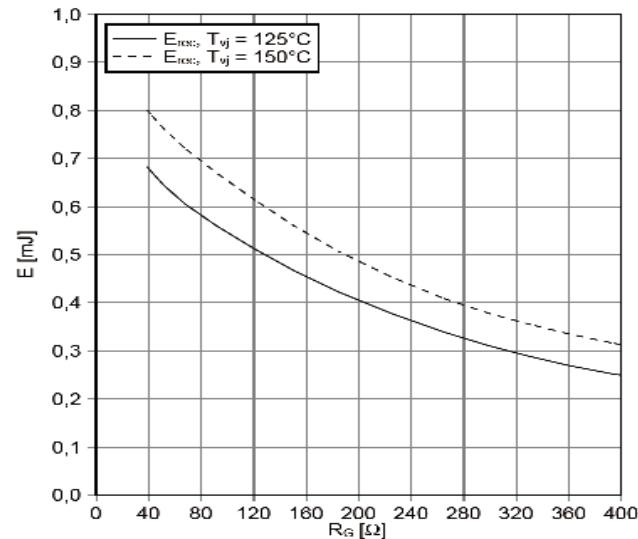
transient thermal impedance Diode, Inverter
 $Z_{thJH} = f(t)$



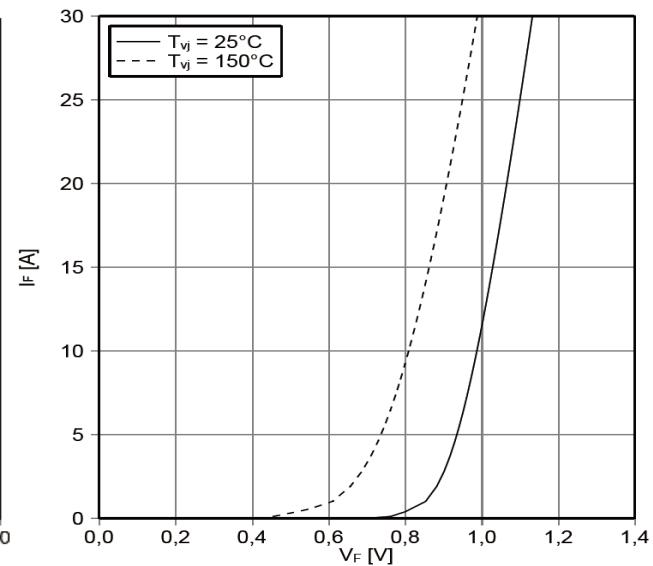
forward characteristic of Diode, Inverter (typical)
 $I_F = f(V_F)$



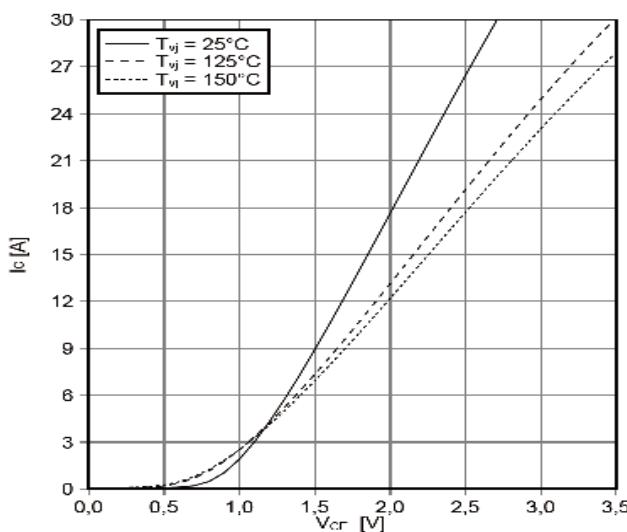
switching losses Diode, Inverter (typical)
 $E_{rec} = f(R_G)$
 $I_F = 15 \text{ A}$, $V_{cr} = 600 \text{ V}$



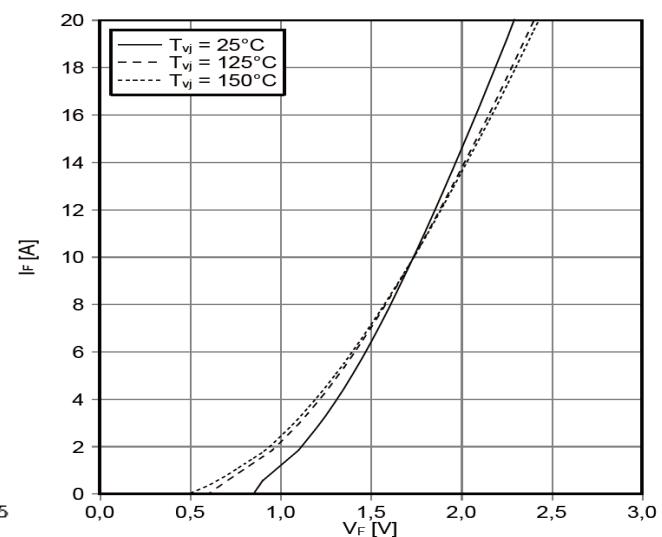
forward characteristic of Diode, Rectifier (typical)
 $I_F = f(V_F)$



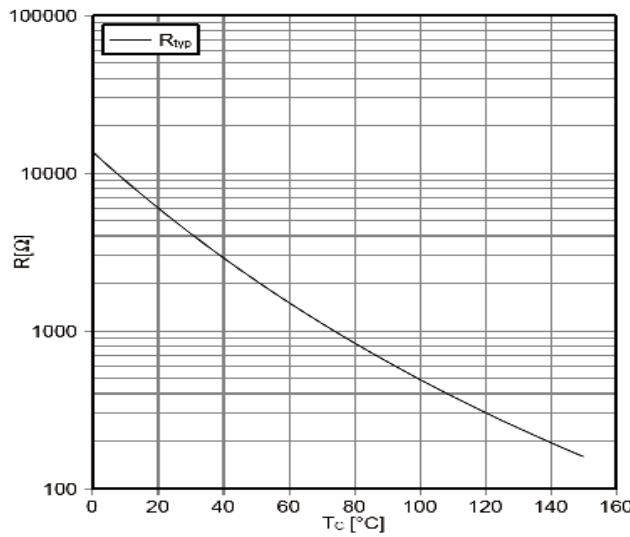
output characteristic IGBT, Brake-Chopper (typical)
 $I_C = f(V_{CE})$
 $V_{GR} = 15 \text{ V}$



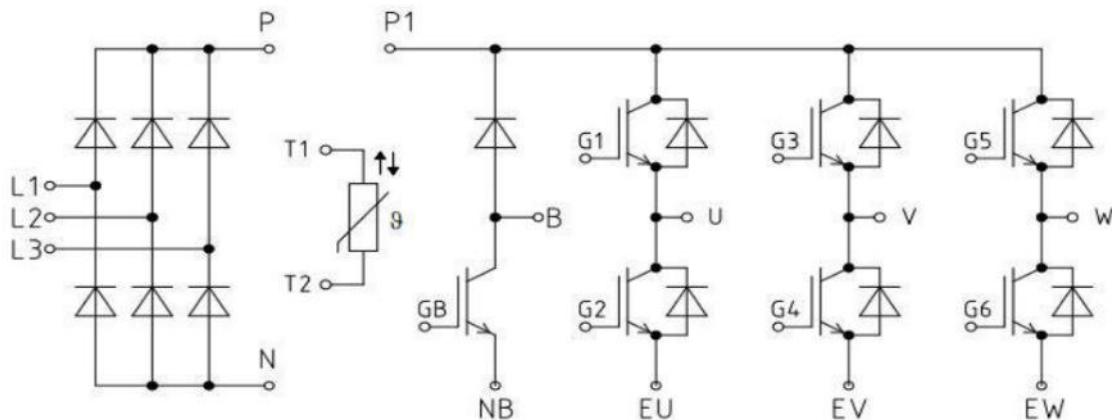
forward characteristic of Diode, Brake-Chopper (typical)
 $I_F = f(V_F)$

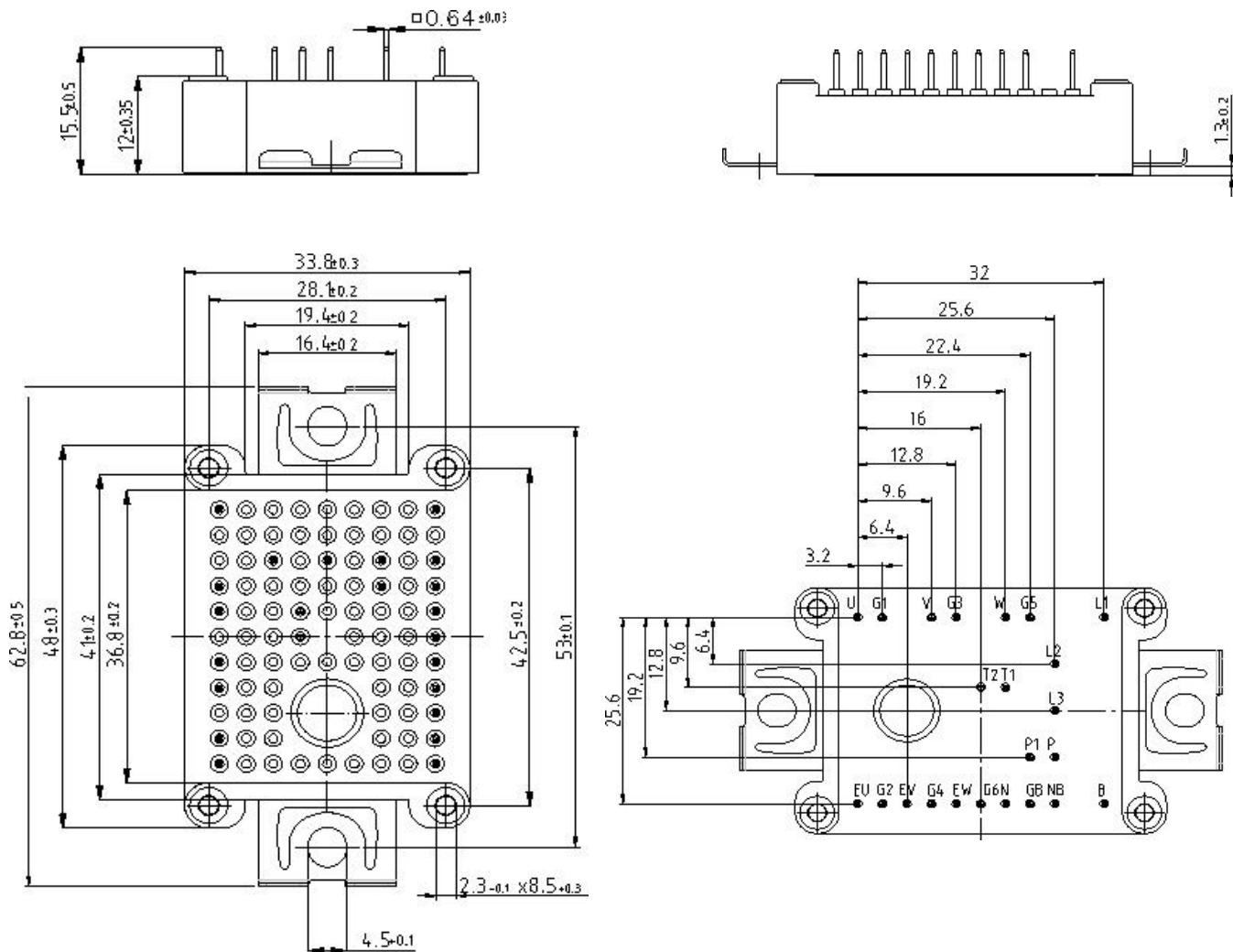


NTC-Thermistor-temperature characteristic (typical)
 $R = f(T)$



Outline:





Outline:258H5P